

<b>Notice of References Cited</b>	Application/Control No. 10/572,576		Applicant(s)/Patent Under Reexamination YONEZAWA ET AL.	
	Examiner LEE D. WILSON		Art Unit 3727	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,095,509	08-2000	Yonezawa, Keitaro	269/309
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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#### NON-PATENT DOCUMENTS

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